

DESCRIPTION

The 5413 and 7413 dual Schmitt triggers consist of two identical Schmitt-trigger circuits in monolithic integrated circuit form. Logically, each circuit functions as a four-input NAND gate, but because of the Schmitt action, the gate has different input threshold levels for positive- and negative-going signals. The hysteresis, or backlash, which is the difference between the two threshold levels, is typically 800mV.

An important design feature is the built-in temperature compensation which ensures very high stability of the threshold levels and the hysteresis over a very wide temperature range. Typically, the hysteresis changes by 3% over the temperature range of -55°C to 125°C and the upper threshold changes by 1% over the same range. The 5413/7413 can be triggered from the slowest of input ramps and still give clean, jitter-free output signals. It can not be triggered from straight dc levels.

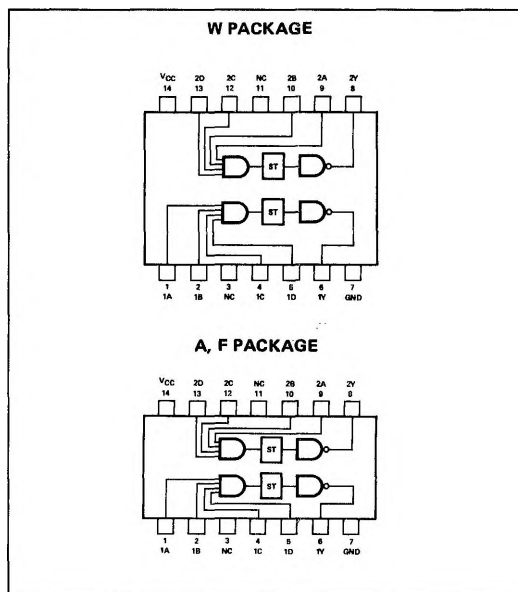
These circuits are fully compatible with most other TTL, DTL, or MSI circuits. The 5413 is characterized for operation over the full military temperature range of -55°C to 125°C ; the 7413 is characterized for operation from 0°C to 70°C .

RECOMMENDED OPERATING CONDITIONS

	5413			7413			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
Supply Voltage V_{CC}	4.5	5	5.5	4.75	5	5.25	V
Fan-Out From Each Output, N			20			20	
High Logic Level			10			10	
Low Logic Level			125			70	
Operating Free-Air Temperature Range, T_A	-55	0	125	0	25	70	$^{\circ}\text{C}$
Maximum Input Rise and Fall Times	No Restriction			No Restriction			

ELECTRICAL CHARACTERISTICS (over recommended operating free-air temperature range unless otherwise noted)

PARAMETER	TEST CONDITIONS*	MIN	TYP**	MAX	UNIT
V_{T+} Positive-going threshold voltage	$V_{CC} = 5\text{V}$	1.5	1.7	2	V
V_{T-} Negative-going threshold voltage	$V_{CC} = 5\text{V}$	0.6	0.9	1.1	V
$V_{T+} - V_{T-}$ Hysteresis	$V_{CC} = 5\text{V}$	0.4	0.8		V
V_I Input clamp voltage	$V_{CC} = \text{MIN}, I_I = -12\text{mA}$			-1.5	V
V_{OH} High-level output voltage	$V_{CC} = \text{MIN}, I_{OH} = -800\mu\text{A}$	2.4	3.3		V
V_{OL} Low-level output voltage	$V_{CC} = \text{MIN}, V_I = 2\text{V}, I_{OL} = 16\text{mA}$		0.22	0.4	V
I_{T+} Input current at positive-going threshold	$V_{CC} = 5\text{V}, V_I = V_{T+}$		-0.65		mA
I_{T-} Input current at negative-going threshold	$V_{CC} = 5\text{V}, V_I = V_{T-}$		-0.85		mA
I_I Input current at maximum input voltage	$V_{CC} = \text{MAX}, V_I = 5.5\text{V}$			1	mA
I_{IH} High-level input current	$V_{CC} = \text{MAX}, V_I = 2.4\text{V}$			40	μA
I_{IL} Low-level input current	$V_{CC} = \text{MAX}, V_I = 0.4\text{V}$		-1	-1.6	mA
I_{OS} Short-circuit output current†	$V_{CC} = \text{MAX}$	-18		-55	mA
I_{CCH} Supply current, high-level output	$V_{CC} = \text{MAX}, V_I = 0$		14	23	mA
I_{CCL} Supply current, low-level output	$V_{CC} = \text{MAX}, V_I = 4.5\text{V}$		20	32	mA



SWITCHING CHARACTERISTICS, $V_{CC} = 5V$, $T_A = 25^\circ C$, $N = 10$

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
t_{PLH}	Propagation delay time, low-to-high-level output	$C_L = 15pF$,	$R_L = 400\Omega$		18	27	ns
t_{PHL}	Propagation delay time, high-to-low-level output	$C_L = 15pF$,	$R_L = 400\Omega$		15	22	ns

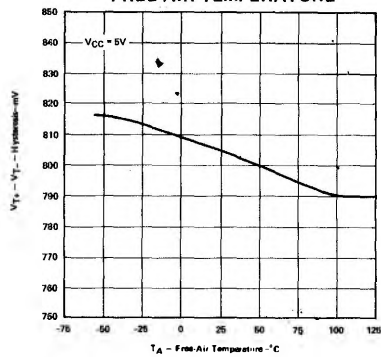
* For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.

** All typical values are at $V_{CC} = 5V$, $T_A = 25^\circ C$.

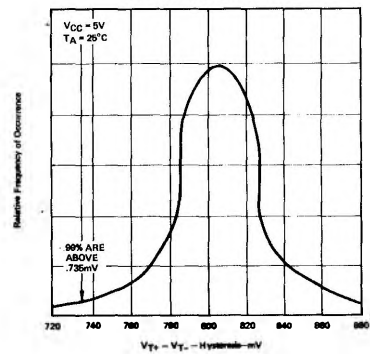
† Not more than one output should be shorted at a time.

TYPICAL CHARACTERISTICS

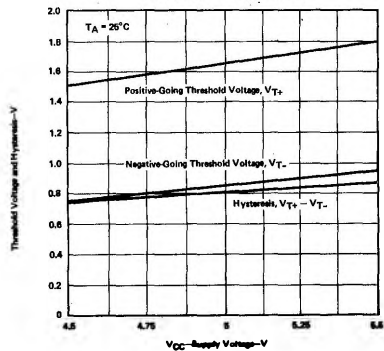
HYSTERESIS
VS
FREE-AIR TEMPERATURE



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